

<b>Notice of References Cited</b>	Application/Control No. 10/689,980	Applicant(s)/Patent Under Reexamination SMART ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0070003	04-2004	Gaska et al.	257/192
	B	US-6,706,576	03-2004	Ngo et al.	438/197
	C	US-6,815,722	11-2004	Lai et al.	257/79
	D	US-5,834,326	11-1998	Miyachi et al.	438/29
	E	US-6,455,877	09-2002	Ogawa et al.	257/99
	F	US-6,110,757	08-2000	Udagawa, Takashi	438/47
	G	US-5,874,747	02-1999	Redwing et al.	257/77
	H	US-5,843,590	12-1998	Miura et al.	428/698
	I	US-2002/0031851	03-2002	Linthicum et al.	438/22
	J	US-2002/0048302	04-2002	KIMURA, AKITAKA	372/46
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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